## **IN THE CLAIMS:**

1. (Currently Amended) A semiconductor device comprising: a semiconductor substrate;

two semiconductor components provided on the principal surface of the surface; and multiple through holes, which pass from the principal surface through the backside of the substrate and are provided in a region of the substrate between the two adjacent components so as to substantially eliminate the electrical interference between the two semiconductor components; and

a conductor film formed directly on the side faces of the through holes.

- 2. (Original) The device of Claim 1, wherein a gap between two adjacent ones of the through holes is smaller than the thickness of the substrate.
  - 3. (Cancelled)
- 4. (Original) The device of Claim 3 further comprising a grounded wiring layer provided on the backside of the substrate,

wherein the conductor film is connected to the grounded wiring layer.

- 5. (Original) The device of Claim 1, wherein each of the components is a power-amplifying transistor for a radio frequency signal.
  - 6. (Previously presented) A semiconductor device comprising:

a semiconductor substrate;

at least two semiconductor components provided on the principal surface of the substrate:

electrodes of the at least two components provided on the substrate;

a first group of through holes, which pass from the principal surface through the backside of the substrate and are provided in respective regions of the substrate under the electrodes;

- a first conductor film provided on the side faces of the first group of through holes;
- a second group of through holes, which pass from the principal surface through the backside of the substrate and are provided in a region of the substrate between the components;
- a second conductor film provided on the side faces of the second group of through holes; and
- a wiring layer, which is provided on the backside of the substrate and is in contact with the first and second conductor films.
- 7. (Original) The device of Claim 6, wherein each of the components is a power-amplifying transistor for an RF signal.
- 8. (Previously presented) The device of Claim 1, where in the multiple through holes stand in a line.
  - 9. (Currently Amended) A semiconductor device comprising:
  - a semiconductor substrate;
- at least two semiconductor components provided on the principal surface of the substrate;

multiple through holes, which pass from the principal surface through the backside of the substrate and are provided in a region of the substrate between at least the two components so as to substantially eliminate the electrical interference between at least the two semiconductor components; and

- a conductor film formed directly on the side faces of the through holes.
- 10. (Previously presented) The device of claim 9 further comprising a grounded wiring layer provided on the backside of the substrate,

wherein the conductor film is connected to the grounded wiring layer.